

From sensors to Dempster-Shafer theory and back : the axiom of ambiguous sensor correctness and its applications
Draheim, Dirk; Tammet, Tanel Database and Expert Systems Applications : 31st International Conference, DEXA 2020, Bratislava, Slovakia, September 14–17, 2020 : Proceedings, Part I 2020 / p. 3-19 https://doi.org/10.1007/978-3-030-59003-1_1 [Conference proceedings at Scopus](#) [Article at Scopus](#) [Conference proceedings at WOS](#) [Article at WOS](#)

Rule-based impact analysis for enterprise business intelligence

Tomingas, Kalle; Tammet, Tanel; Kliimask, Margus Artificial Intelligence Applications and Innovations : AIAI 2014 Workshops : CoPA, MHDW, IVC, and MT4BD, Rhodes, Greece, September 19-21, 2014 : proceedings 2014 / p. 302-309 : ill https://doi.org/10.1007/978-3-662-44722-2_32 [Conference proceedings at Scopus](#) [Article at Scopus](#)